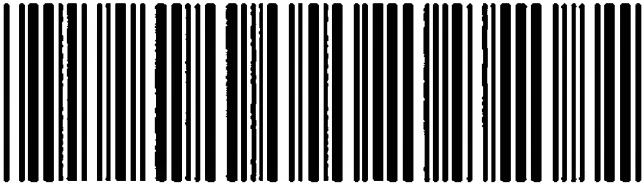


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/622,313	BARDEN ET AL.	
	Examiner	Art Unit	
	Jon M. Lockard	1647	

SEARCHED			
Class	Subclass	Date	Examiner
NONE		11/15/2006	JML

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
STIC Search of SEQ ID NO:1; See sequence search results in SCORE.	9/29/2006	JML
East Search (USPAT, US-PGPUB, EPO, DERWENT): Inventor Name and Text Search. See Attached Search History.	11/15/2006	JML
STN (MEDLINE, SCISEARCH, EMBASE, BIOSIS): See Attached Search History.	9/30/2006	JML
PALM: Inventor Search	11/15/2006	JML